

Registration (Fax Reply)

To: ECPE e.V.
Att.: Ingrid Bollens, Ingrid.bollens@ecpe.org
Please **e-mail** a scanned copy of the completed form or
send a fax to: +49 (0)911 / 81 02 88 – 28

Register before **23 Juni 2011**

Participation fee:

- € 530,- * for industry
- € 395,- * for universities/institutes
- € 120,- * for students (shortened workshop package)

The fee includes dinner, lunch, coffee/soft drinks and a CD with the workshop presentations. A printed version of the workshop handout is available on request (€ 42,-*).

With the confirmation of registration you will receive the invoice. (* plus VAT) In case of cancellation after 23 June 2011 or non-attendance 50 % of the participation fee are payable.

Three participants from each ECPE member company free of charge. Allocation in sequence of registration.

Sender:

Title, given name, name

Company, department

Full address

Phone, fax

E-mail

Date, signature

F06-110622

Organisational information

Organiser	ECPE e.V. 90443 Nuremberg, Germany www.ecpe.org
Chairman	Prof. Hans-Günter Eckel, Universität Rostock Dr. Stefan Zeltner Fraunhofer IISB Erlangen Dipl.-Ing.(FH) Jochen Koszescha ECPE e.V.
Organisation	Ingrid Bollens, ECPE e.V. +49 (0)911 / 81 02 88 – 10 ingrid.bollens@ecpe.org
Workshop venue	Commundo Tagungshotel Ismaning Seidl-Kreuz-Weg 11 85737 Ismaning/Munich Germany



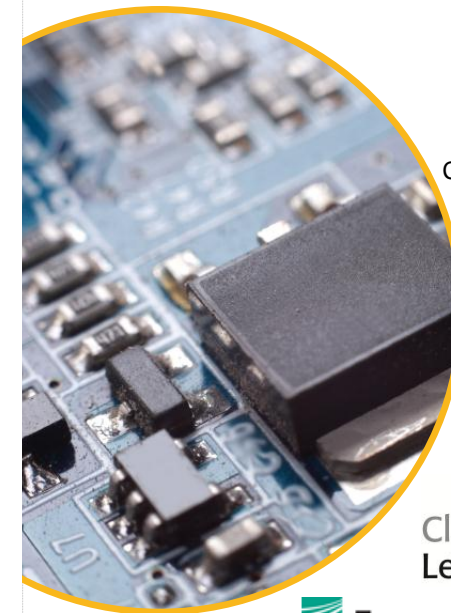
Further information (hotel list and maps) will be provided after registration.



ECPE Workshop

Electronics around the Power Switch:

Gate Drivers, Sensors and Control



29 - 30 June 2011
Commundo Tagungshotel
Ismaning-Munich
Germany

in cooperation with


Cluster
Leistungselektronik



Electronics around the Power Switch: Gate Drivers, Sensors and Control

29 - 30 June 2011
Munich, Germany

The goal of this workshop is to present the actual status of electronic devices and circuits around the power switches which are necessary to realize the complete power stage.

Besides the power switches itself, the gate driver is the component, which has the strongest impact on the performance and the reliability of the power stage and requires power semiconductor and electronic circuit know how. So a lesson about the switching behaviour of IGBTs and diodes lays the basis to understand the demands on the gate drive. It is followed by presentations over different approaches and necessary components and functionality of IGBT and MOSFET gate drivers and the philosophy behind them. Driver cores allow the adaption to application specific demands while plug-and-play drives promise a short development time. Also some commercial available ready for use solutions will be presented and discussed.

For low to medium power and voltage, intelligent power modules with integrated drivers offer an interesting solution for fast and low-risk developments, but shift know-how and added value from the inverter to the module manufacturer.

For current sensing, open- and close-loop magnetic as well as shunt sensors are available, including ICs for AD conversion and potential isolation. Potential-free and quasi potential free voltage sensors are discussed as well as measurement systems for laboratory use.

An outlook on hardware for inverter control, especially full FPGA integrated solutions, completes this seminar.

The workshop is chaired by Prof. H.-G. Eckel (University Rostock) and Dr. S. Zeltner (Fraunhofer IISB Erlangen) and J. Koszescha (ECPE). All presentations and discussions will be in English.

There will be a tabletop exhibition in the frame of the workshop.

Wednesday, 29 June 2011

10:00 Start of Registration / Welcome Coffee

10:30 **Welcome, Opening**
H.G. Eckel, Universität Rostock
S. Zeltner, Fraunhofer IISB Erlangen
T. Harder, ECPE e.V.

Introduction

10:45 **Power Semiconductor Fundamentals – What happens inside the IGBT during switching?**
H.G. Eckel, Universität Rostock

11:15 **Switching Behaviour of Power Switches (IGBT, MOSFET)**
R. Bayerer, Infineon Technologies

11:45 **Principles of Low-Loss Gate Driver Circuits**
S. Zeltner, Fraunhofer IISB Erlangen

12:15 **Discussion**

12:30 Lunch

The Potential of Gate Drivers

13:30 **Concept for a Digital Adaptive Gate Unit**
L. Dang Hung, A. Mertens, University of Hannover

14:00 **Intelligent Digital Gate Driver**
R. Hemmer, InPower

14:30 **Skip IV: Integration of a new Digital Driver Concept**
A. Winterholler, Semikron Elektronik

15:00 **HVDC IGBT Driver as Simple and Reliable as Possible**
M. Billmann, Fraunhofer IISB Nuremberg

15:30 **Discussion**

15:45 Coffee Break

Auxiliary Functions related to Gate Drivers

16:15 **Extended Functionality in Gate Drivers for Traction Applications**
L. Montoya, ABB Switzerland

16:45 **Switching Optimization and Protection using Active Clamping**
S. Pawel, CT-Concept Technologie

17:15 **High Frequency Transformers for Signal and Power Isolation of Gate Drives**
K. McGivern, Bicon Electronics

17:45 **Smart Gate Drivers – Protection and Level Shifting**
U. Kirchenberger, L. Salati, STMicroelectronics

18:15 **Discussion**

18:30 **End of 1st Day**

19:30 Dinner

Thursday, 30 June 2011

8:25 Start of 2nd Day

8:25 **Wrap up of 1st workshop day**

Sensors & Measurements

8:30 **Voltage, Current and Temperature Measurement Concepts Enabling Intelligent Gate Drives**
Y. Lobsiger, ETH Zurich

9:00 **Current Sensors with Magnetic Probe**
D. Steuer, Vacuumschmelze

9:30 **Magneto Resistive Current Sensors with very high Bandwidth**
S. Scherner, G. von Manteuffel, Sensitec

10:00 **Discussion**

10:15 Coffee break

10:45 **Shunts – Current Sensors with a high Potential of Integration**
U. Schwarzer, Infineon Technologies

11:15 **Measurement of Low and High Voltages with Sigma Delta approach**
J.O. Krahl, Cologne University of Applied Science

11:45 **Advance Methods of Temperature Measurement of Power Switches**
E. Hoene, Fraunhofer IZM Berlin

12:15 **Discussion**

12:30 Lunch

Conditioning of Sensor Signals / Control Concepts for High Integration

13:30 **Realisation of the Control of a three Level Inverter within a FPGA**
J.O. Krahl, Cologne University of Applied Science

14:00 **Direct Digital Current Control, an Alternative to PWM Control**
A. Ackva, University of Applied Science Würzburg-Schweinfurt

14:30 **Case Study: Power Management Solutions**
H. Werner, Lattice Semiconductor

14:50 **Galvanic isolated Measurement and Command of Signals**
B. Strzalkowski, Analog Device

15:20 **Case Study: Wireless Voltage Probe for Accurate Voltage Measurement on High and Transient Reference Voltages**
Y. Lobsiger, ETH Zurich

15:40 **Final Discussion**

16:00 End of Workshop